



# MEASUREMENT REPORT

## EN 300 330 V2.1.1

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**Applicant:** BEIJING STRONGLINK TECHNOLOGY CO., LTD.

**Address:** Building C No.39 Xi'erqi street Haidian district, Beijing,  
100085 China

**Product:** MIFARE MODULE

**Model No.:** SL030\_V3.1

**Serial Model No.:** SL031\_V3.0

**Standards:** ETSI EN 300 330 V2.1.1 (2017-02)

**Result:** Complies

**Test Date:** April 15 ~ 25, 2019

Reviewed By : Sunny Sun  
( Sunny Sun )

Approved By : Robin Wu  
( Robin Wu )



The test results relate only to the samples tested.

The test results shown in the test report are traceable to the national/international standards through the calibration of the equipment and evaluated measurement uncertainty herein.

The test report shall not be reproduced except in full without the written approval of MRT Technology (Suzhou) Co., Ltd.

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### Revision History

Report No.	Version	Description	Issue Date	Note
1903RSU035-E1	Rev. 01	Initial Report	05-05-2019	Valid

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## 1. General Information

### 1.1. Applicant

BEIJING STRONGLINK TECHNOLOGY CO., LTD.

Building C No.39 Xi'erqi street Haidian district, Beijing, 100085 China

### 1.2. Manufacturer

BEIJING STRONGLINK TECHNOLOGY CO., LTD.

Building C No.39 Xi'erqi street Haidian district, Beijing, 100085 China

### 1.3. Testing Facility

#### Test Site

MRT Technology (Suzhou) Co., Ltd

#### Test Site Location

D8 Building, Youxin Industrial Park, No.2 Tian'edang Rd., Wuzhong Economic Development Zone, Suzhou, China

### Test Facility / Accreditations

Measurements were performed at MRT Laboratory located in Tian'edang Rd., Suzhou, China.

- MRT facility is a FCC registered (MRT Reg. No. 893164) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules.
- MRT facility is an IC registered (MRT Reg. No. 11384A-1) test laboratory with the site description on file at Industry Canada.
- MRT facility is a VCCI registered (R-20025, G-20034, C-20020, T-20020) test laboratory with the site description on file at VCCI Council.
- MRT Lab is accredited to ISO 17025 by the American Association for Laboratory Accreditation (A2LA) under the American Association for Laboratory Accreditation Program (A2LA Cert. No. 3628.01) in EMC, Telecommunications and Radio testing for FCC, Industry Canada, EU and TELEC Rules.



#### 1.4. Feature of Product

Product Name:	MIFARE MODULE
Model No.:	SL030_V3.1
Serial Model No.:	SL031_V3.0
RFID:	13.56MHz
Antenna Type:	PCB Antenna
Type of modulation:	ASK

Note: The two models only have different names, and the others are all same.

#### 1.5. Standards Applicable for Testing

The EUT complies with the requirements of ETSI EN 300 330 V2.1.1

## 2. Test Summary

Clause (EN 300330)	Test Parameter	Result (Pass/Fail)	Remark
<b>Transmitter Parameter</b>			
4.3.1	Permitted range of operating frequencies	Pass	--
4.3.2	Operating frequency ranges	Pass	--
4.3.3	Modulation Bandwidth	Pass	--
4.3.4	Transmitter H-field requirements	Pass	--
4.3.5	Transmitter RF carrier current	N/A	Note 3
4.3.6	Transmitter radiated E-field requirements	N/A	Note 3
4.3.7	Transmitter conducted spurious emissions	N/A	Note 3
4.3.8	Transmitter radiated spurious domain emission limits < 30 MHz	Pass	--
4.3.9	Transmitter radiated spurious domain emission limits > 30 MHz	Pass	--
4.3.10	Transmitter Frequency stability	N/A	Note 3
<b>Receiver Parameter</b>			
4.4.2	Receiver spurious emissions	N/A	Note 3
4.4.3	Adjacent channel selectivity	N/A	Note 3
4.4.4	Receiver blocking or desensitization	N/A	Note 3
<p>Note:</p> <ol style="list-style-type: none"> <li>1. This device belongs to Product Class 3.</li> <li>2. For radiated spurious emission test, every axis (X, Y, Z) was also verified. The test results shown in the following sections represent the worst case emissions.</li> <li>3. "N/A" means that the test item is not applicable, and the detailed information refers to relevant section.</li> </ol>			

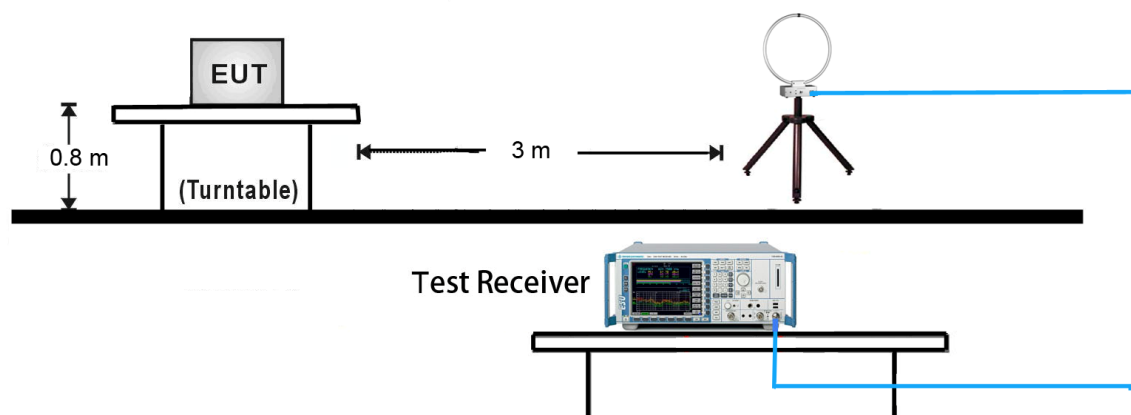


### 3. Permitted Range of Operating Frequencies

#### 3.1. Limit

The permitted range of operating frequencies for intentional emissions shall be entirely within the frequency bands in table 1.

#### 3.2. Test Setup



#### 3.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.2

### 3.4. Test Result

Test Engineer	Snake Ni	Test Site	AC1
Test Time	04-22-2019	Temperature	23°C
Test Mode	Mode1	Relative Humidity	50%RH

Test Conditions		Frequency (MHz)
T <sub>NOM</sub> (25°C)	V <sub>NOM</sub> (AC 230V)	13.560
Test Result		Pass

Note 1: The operating frequency of the EUT is 13.560MHz and it is declared by the manufacturer.

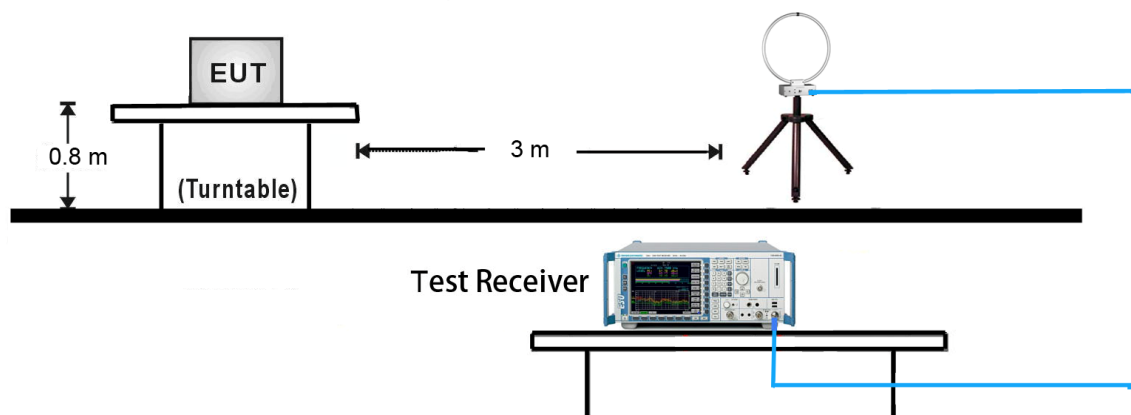
Note 2: 11.810MHz < 13.560MHz < 15.310MHz.

## 4. Operating Frequency Ranges

### 4.1. Limit

The operating frequency ranges for intentional emissions shall be entirely within the frequency bands in table 1.

### 4.2. Test Setup

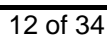


### 4.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.2

Test Engineer	Snake Ni	Test Site	AC1
Test Time	04-25-2019	Temperature	23°C
Test Mode	Mode1	Relative Humidity	50%RH

Note:  $11.810\text{MHz} < 13.562\text{MHz} < 15.310\text{MHz}$ .



## 5. Modulation Bandwidth

### 5.1. Limit

The modulation bandwidth shall be within the assigned frequency band see table 1 or  $\pm 7,5\%$  of the carrier frequency whichever is the smallest. For RFID and EAS Systems, the modulation bandwidth shall be within the transmitter emission boundary of figures I.1, I.2, I.3 and I.4 of ETSI EN 300 330 V2.1.1 (2017-02).

The EUT belongs to the narrowband RFID, and the figure I.4 of ETSI EN 300 330 V2.1.1 (2017-02) as below applies to the EUT.

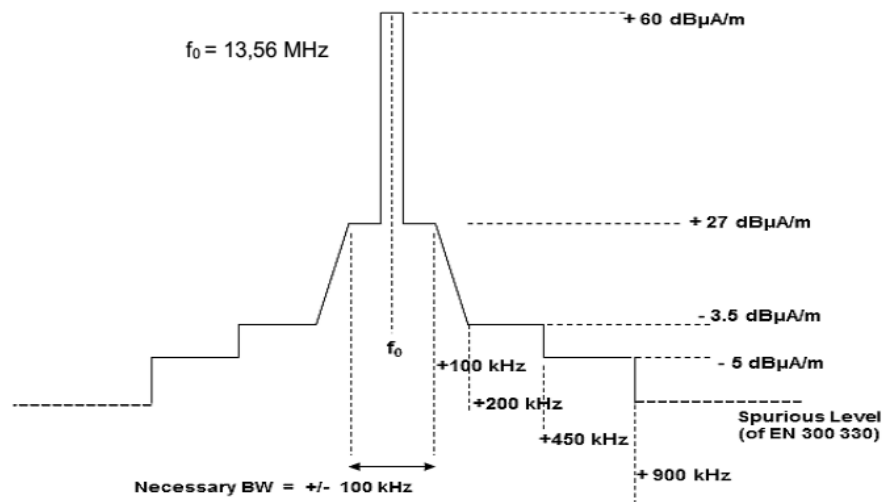
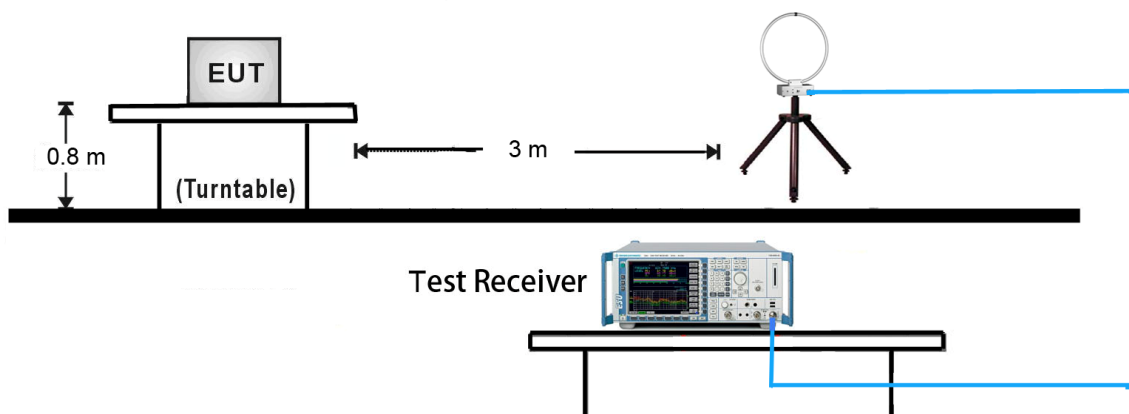


Figure I.4: Spectrum mask limit for narrowband RFIDs (incl. NFC application) in the 13,56 MHz range

### 5.2. Test Setup



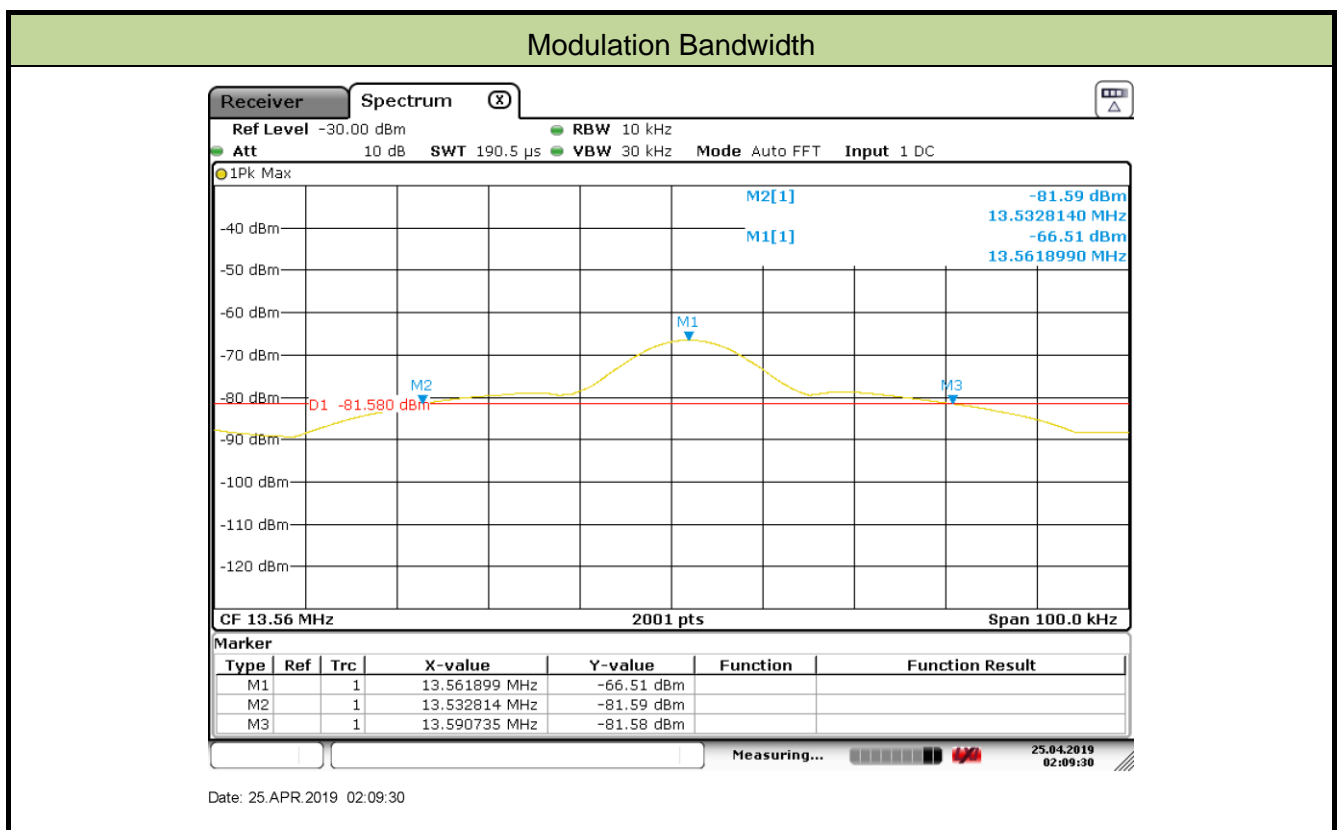
### **5.3. Test Procedure**

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.3

## 5.4. Test Result

Test Engineer	Snake Ni	Test Site	AC1
Test Time	04-25-2019	Temperature	23°C
Test Mode	Mode1	Relative Humidity	50%RH

Test Conditions		Low Frequency (F <sub>L</sub> ) (MHz)	F <sub>L</sub> Limit (MHz)	High Frequency (F <sub>H</sub> ) (MHz)	F <sub>H</sub> Limit (MHz)
T <sub>NOM</sub> (25°C)	V <sub>NOM</sub> (AC 230V)	13.533	> 12.660	13.591	< 14.460
Test Result		Pass			



## 6. Transmitter H-field Requirements

### 6.1. Limit

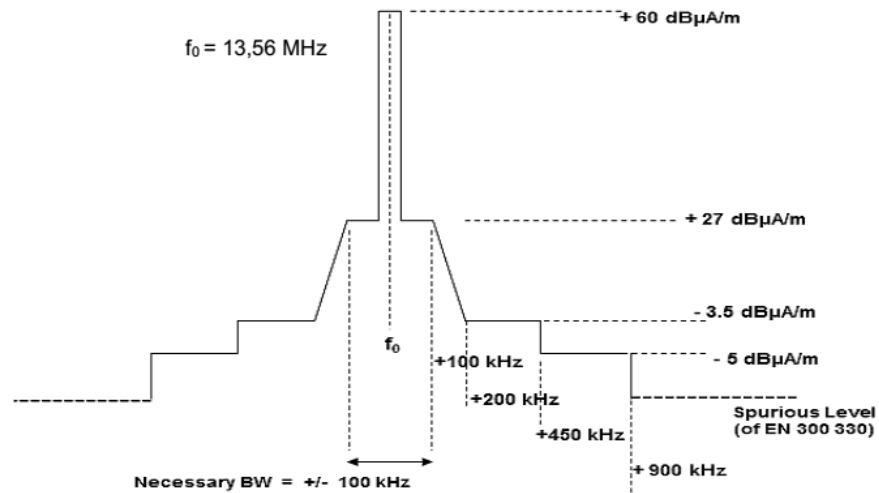
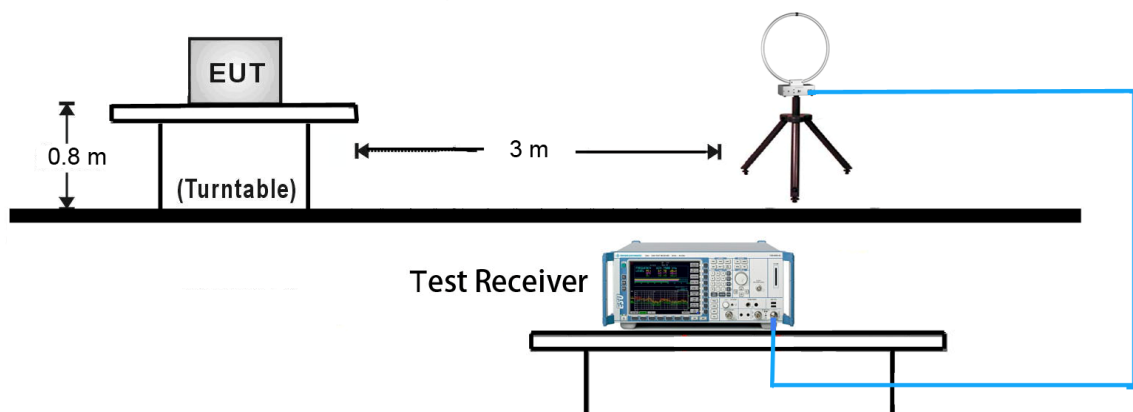


Figure I.4: Spectrum mask limit for narrowband RFIDs (incl. NFC application) in the 13,56 MHz range

### 6.2. Test Setup



### 6.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.4



## 6.4. Test Result

Test Engineer	Bacon Dong	Test Site	AC1
Test Time	04-15-2018	Temperature	23°C
Test Mode	Mode1	Relative Humidity	50%RH

Frequency (MHz)	Reading Level (dBuV/m)	Factor	3M Measure Level (dBuV/m)	10M Measure Level (dBuV/m)	10M Measure Level (dBuA/m)	10M Limit (dBuA/m)	Margin (dB)
Face On							
12.791	8.4	19.8	28.2	17.7	-33.8	-5.0	-28.8
13.344	15.1	19.8	34.9	24.4	-27.1	-3.5	-23.6
13.418	15.9	19.9	35.8	25.3	-26.2	8.7	-34.9
13.493	16.3	19.9	36.2	25.7	-25.8	27.0	-52.8
13.553	37.5	19.9	57.4	46.9	-4.6	60.0	-64.6
13.627	18.4	19.9	38.3	27.8	-23.7	27.0	-50.7
13.702	14.5	19.9	34.4	23.9	-27.6	14.8	-42.4
13.777	16.8	19.9	36.7	26.2	-25.3	-3.5	-21.8
14.224	7.7	19.8	27.5	17.0	-34.5	-5.0	-29.5
Face Off							
13.015	8.7	19.8	28.5	18.0	-33.5	-5.0	-28.5
13.344	12.4	19.8	32.2	21.7	-29.8	-3.5	-26.3
13.418	12.3	19.9	32.2	21.7	-29.8	8.7	-38.5
13.493	13.5	19.9	33.4	22.9	-28.6	27.0	-55.6
13.553	34.1	19.9	54.0	43.5	-8.0	60.0	-68.0
13.627	14.1	19.9	34.0	23.5	-28.0	27.0	-55.0
13.717	9.2	19.9	29.1	18.6	-32.9	14.8	-47.7
13.777	10.7	19.9	30.6	20.1	-31.4	-3.5	-27.9
14.030	8.1	19.8	27.9	17.4	-34.1	-5.0	-29.1

Note 1: Measure Level = Reading Level + Factor.

Note 2:  $L2 = L1 + 20 \log(d1/d2)$ ,  $L2$  = 10M Measure Level,  $L1$  = 3M Measure Level.

Note 3: For measuring equipment calibrated in dBuV, the reading should be reduced by 51.5dB to be converted to dBuA/m.

Note 4: The Max EIRP =  $E_{Max} + 20 \cdot \log(d_{Meas}) - 104.7 = (57.4 + 20 \cdot \log(3) - 104.7)$  dBm = -37.76 dBm.

## 7. Transmitter RF Carrier Current

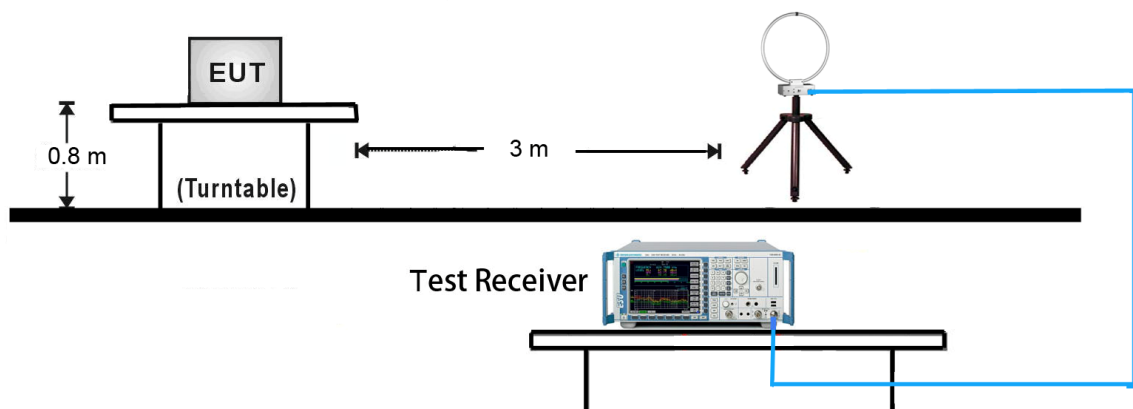
### 7.1. Limit

Limit for RF carrier current x antenna area (for Product Class 3 only)	
Frequency range (MHz)	RF carrier current x antenna area, dBAm <sup>2</sup>
$0.119 \leq f < 0.135$	40 descending 3 dB/oct above 30 KHz (see note)

Note: Limit is 10 dBAm<sup>2</sup> for the following spot frequencies:

60 kHz  $\pm$  250 Hz, 75 kHz  $\pm$  250 Hz, 77.5 kHz  $\pm$  250 Hz and 129.1 kHz  $\pm$  500 Hz.

### 7.2. Test Setup



### 7.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.5

### 7.4. Test Result

The transmitter in the EUT is belongs to Product Class 1 and this requirement applies to Product Class 3 only, therefore this requirement does not apply.

## 8. Transmitter Radiated E-field

### 8.1. Limit

In the frequency range 9 kHz to 4.78 MHz, the limits of  $H_{ef}$  follow the H-fields limits,  $H_f$ , as given in clause 4.3.4.3, table 2 with an additional correction factor C. The factor given below is specific for a 10m measuring distance.

The limit  $H_{EF} = H_F + C$

where:

$$C = 20 \times \log (F_C / 4,78 \times 10^6) \text{ dB};$$

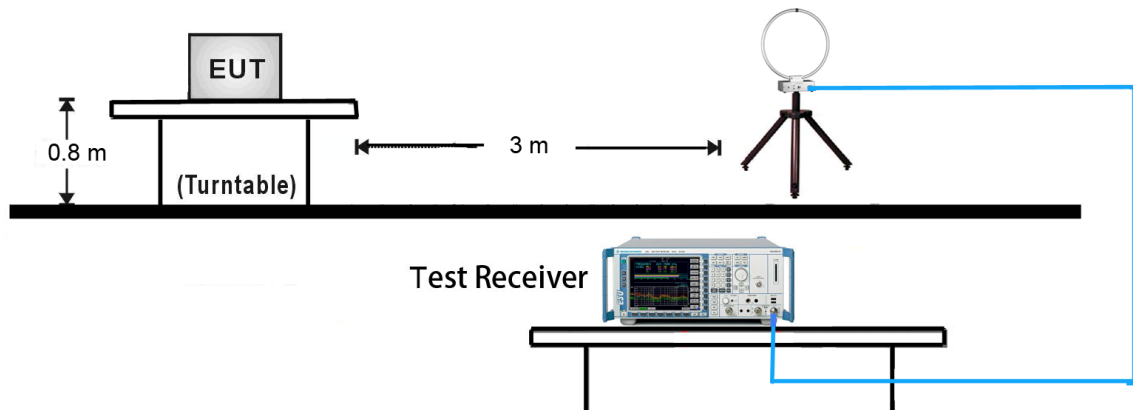
and where:

$F_C$  is the carrier frequency in Hz.

For a graphical representation of the correction factor C see annex D.

In the frequency range 4.78 MHz to 25 MHz limits are identical to the limits in clause 4.3.4.3, table 2, without any correction factor.

### 8.2. Test Setup



### 8.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.6

### 8.4. Test Result

The transmitter in the EUT is belongs to Product Class 1 and this requirement applies to Product Class 4 only, therefore this requirement does not apply.

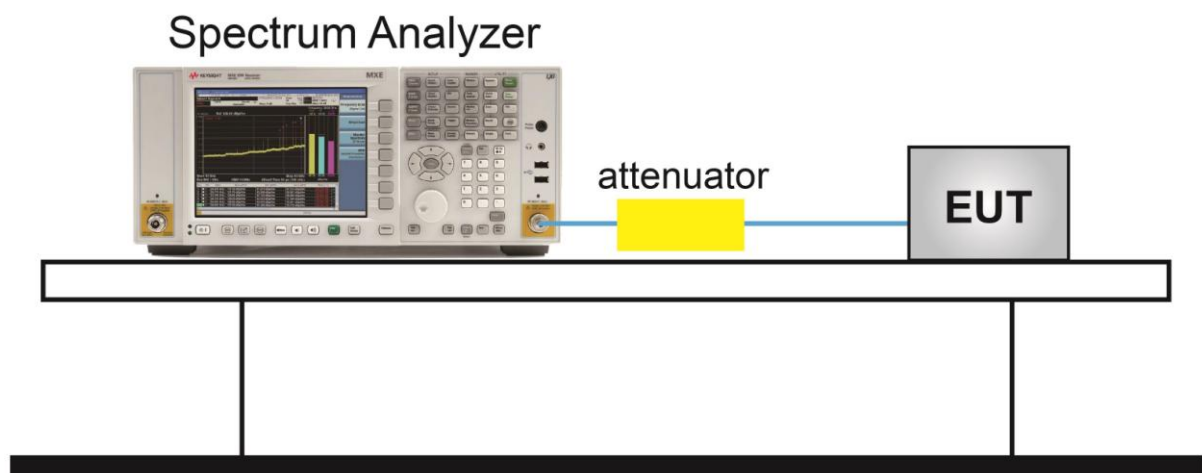
## 9. Transmitter Conducted Spurious Emissions

### 9.1. Limit

The limit for  $I_S$  will be derived from the below formula with the existing limits of  $H_C$  (see clause 4.3.4),  $H_S$  (see clause 4.3.8) and  $I_C$  (see clause 4.3.5).

$$(I_C - I_S) = (H_C - H_S)$$

### 9.2. Test Setup



### 9.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.7

### 9.4. Test Result

The transmitter in the EUT is belongs to Product Class 1 and this requirement applies to Product Class 3 only, therefore this requirement does not apply.

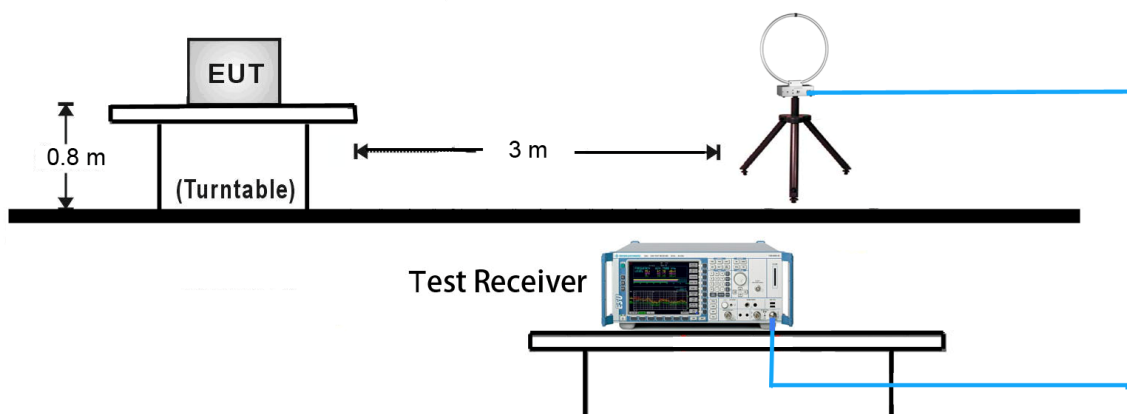
## 10. Transmitter Radiated Spurious Domain Emission Limits < 30 MHz

### 10.1. Limit

The radiated field strength of the spurious domain emissions below 30 MHz shall not exceed the generated H-field dB $\mu$ A/m at 10 m.

State	Frequency $9\text{kHz} \leq f \leq 10\text{MHz}$	Frequency $10\text{MHz} \leq f \leq 30\text{MHz}$
Operating	27dB $\mu$ A/m at 9 kHz descending 3 dB/oct	-3.5dBuA/m
Standby	5.5dB $\mu$ A/m at 9 kHz descending 3 dB/oct	-25dBuA/m

### 10.2. Test Setup



### 10.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.8

## 10.4. Test Result

Test Engineer	Bacon Dong	Temperature	25°C
Test Time	04-15-2019	Relative Humidity	54%
Test Mode	Mode1	Test Site	AC1

Frequency (MHz)	Reading Level (dBuV/m)	Factor (dB)	3M Distance Measure Level (dBuV/m)	10M Distance Measure Level (dBuV/m)	10M Distance Measure Level (dBuA/m)	10M Distance Limit (dBuA/m)	Margin [dB]
Face On							
27.120	6.0	19.5	25.5	15.0	-36.5	-3.5	-33.0
Face Off							
27.120	7.0	19.5	26.5	16.0	-35.5	-3.5	-32.0

Note 1: Measure Level (dBm) = Reading Level (dBm) + Factor (dB);

Note 2:  $L2 = L1 + 20 \log(d1/d2)$ ,  $L2 = 10M$  Measure Level,  $L1 = 3M$  Measure Level;

Note 3: For measuring equipment calibrated in dBuV, the reading should be reduced by 51.5dB to be converted to dBuA/m.

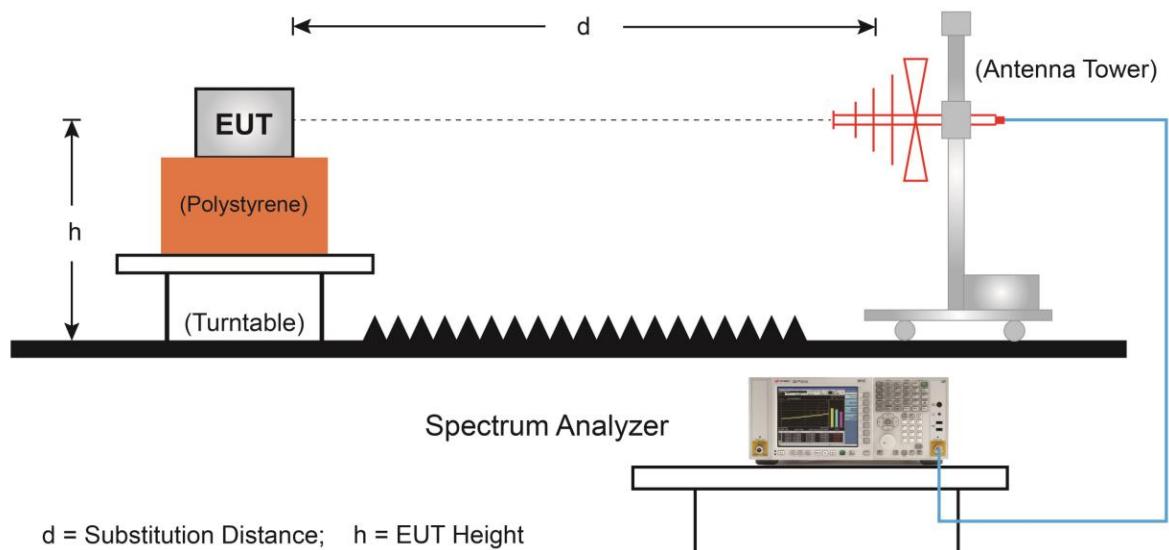
## 11. Transmitter Radiated Spurious Domain Emission Limits > 30 MHz

### 11.1. Limit

The power of any radiated emission shall not exceed the values on below.

Transmitter State	47MHz to 74MHz 87.5MHz to 118MHz 174MHz to 230MHz 470MHz to 790MHz	Other frequencies between 30MHz to 1000MHz
Operating	4nW	250nW
Standby	2nW	2nW

### 11.2. Test Setup



### 11.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.9.

#### 11.4. Test Result

Test Engineer	Snake Ni	Temperature	25°C
Test Time	04-15-2019	Relative Humidity	54%
Test Mode	Mode1	Test Site	AC1

Frequency (MHz)	Reading Level (dBm)	Factor (dB)	Measure Level (dBm)	Limit (dBm)	Margin [dB]	Polarization
66.4	-87.0	22.5	-64.5	-54.0	-10.5	Horizontal
732.3	-102.4	34.8	-67.6	-54.0	-13.6	Horizontal
73.2	-85.3	22.4	-62.9	-54.0	-8.9	Vertical
732.3	-102.8	34.0	-68.8	-54.0	-14.8	Vertical

Note 1: Measure Level (dBm) = Reading Level (dBm) + Substitution Factor (dB)

Note 2: Substitution Factor (dB) = Cable Loss (dB) + Space Attenuation (dB) + Antenna Factor (dB/m)  
- Pre\_Amplifier Gain (dB)



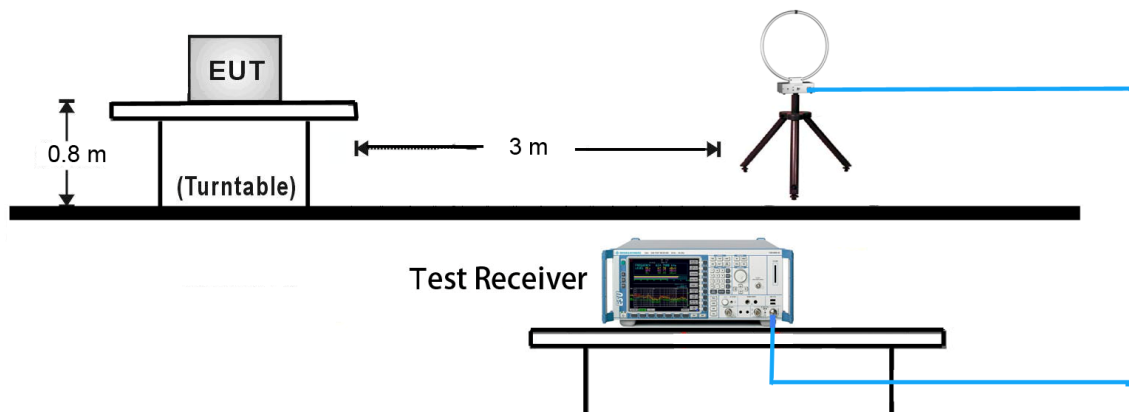
## 12. Transmitter Frequency Stability

### 12.1. Limit

The equipment shall either:

- a) remain in the Operating Channel without exceeding any applicable limits (e.g. Duty Cycle); or
- b) reduce its effective radiated power below the Spurious Emission limits without exceeding any applicable limits (e.g. Duty Cycle); or
- c) shut down, (e.g. no emission above EMC levels).

### 12.2. Test Setup



### 12.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.2.10.

### 12.4. Test Result

The item is only applicable for channelized systems, so this EUT is not applicable.

## 13. Receiver Spurious Emissions

### 13.1. Limit

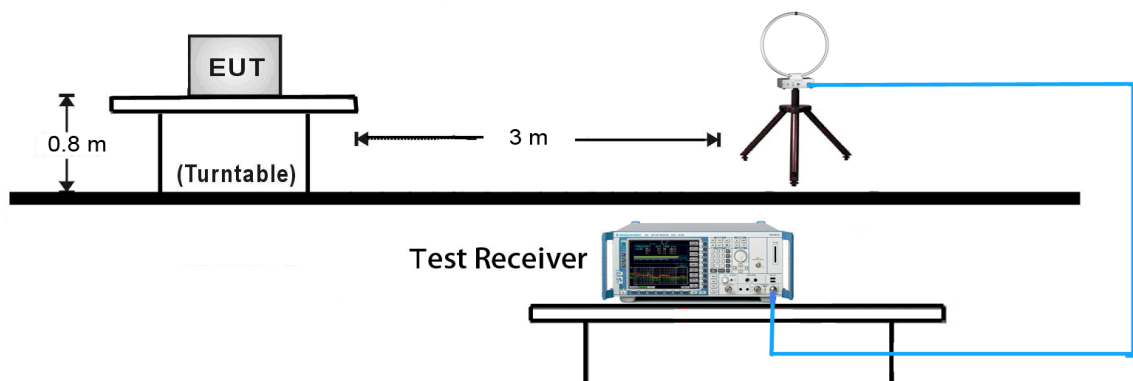
The spurious components below 30 MHz shall not exceed the generated H-field dB $\mu$ A/m values at 10 m.

Frequency $9 \text{ kHz} \leq f < 10 \text{ MHz}$	Frequency $10 \text{ MHz} \leq f < 30 \text{ MHz}$
5.5dB $\mu$ A/m descending 3dB/oct	-25dB $\mu$ A/m

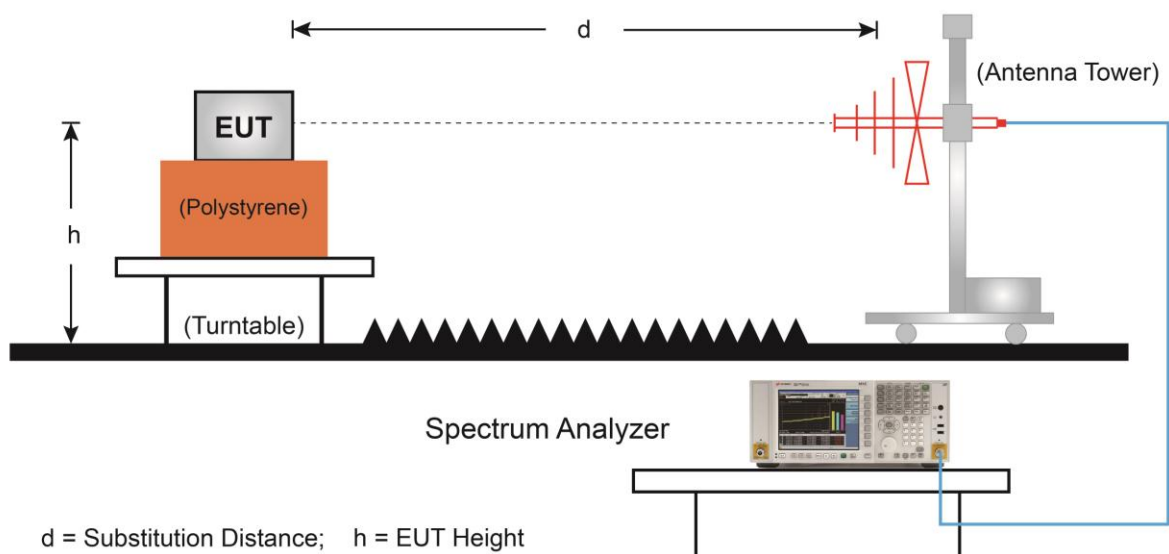
The spurious components above 30 MHz measured values shall not exceed 2nW.

### 13.2. Test Setup

9kHz ~ 30MHz Test Setup:



30MHz ~ 1GHz Test Setup:



### **13.3. Test Procedure**

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.3.1

### **13.4. Test Result**

The receiver in the EUT is collocated with the transmitter that is continuously transmitting; the receiver was tested along with the transmitter in operating mode; therefore this requirement does not apply.

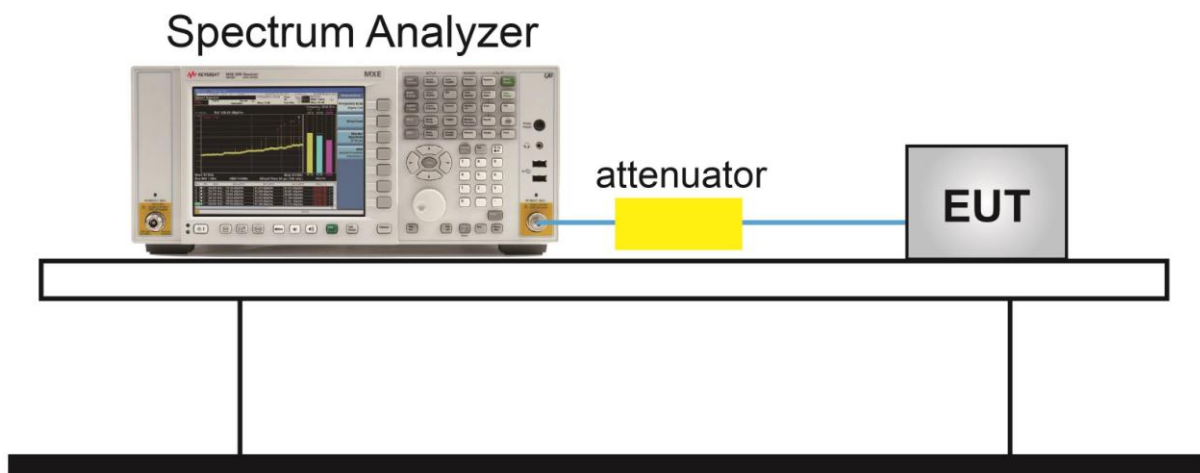
## 14. Adjacent Channel Selectivity

### 14.1. Limit

The receiver selectivity of the equipment under specified conditions shall not be less than stated as below.

Channel spacing $\leq 25\text{KHz}$	Channel spacing $> 25\text{KHz}$
60dB	70dB

### 14.2. Test Setup



### 14.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.3.2

### 14.4. Test Result

This measurement is only for channelized systems and only required where a frequency plan with standard channel spacing is consistently used, for example at 27 MHz, therefore this requirement does not apply.

## 15. Receiver Blocking or Desensitization

### 15.1. Limit

The blocking ratio, for any frequency within the specified ranges, shall not be less than the values given in table 10, except at frequencies on which spurious responses are found. The limit value is determined by a reference limit (Ref) multiplied by a correction factor depending of the appropriate receiver category.

**Table 10: Receiver blocking or desensitization limits**

Generator B frequency offset, $ f_A - f_B $ , either by a) or b) whichever is greater (see note 3)			Limit (dB)
a) per clause 7.4, indent a)		b) per clause 7.4, indent b)	
$f_A < 500$ kHz	$f_A \geq 500$ kHz	value of $N_B$ , see below	
$\pm 100$ kHz	$\pm 500$ kHz	2	Reference Limit $\times 1/2$ (see note 2)
$\pm 200$ kHz	$\pm 1$ MHz	4	Reference Limit $\times 2/3$ (see note 2)
$\pm 300$ kHz	$\pm 2$ MHz	8	Reference Limit $\times 5/6$ (see note 2)
$\pm 500$ kHz	$\pm 5$ MHz	20	Reference Limit (see note 1)
NOTE 1: Reference limit (Ref) = 30 dB at 9 kHz increasing with 10 dB/decade to 65,2 dB at 30 MHz.			
NOTE 2: The limit is a fractional dB value of the reference limit.			
NOTE 3: Generator B frequencies below 9 kHz are not specified.			

### 15.2. Test Setup

N/A

### 15.3. Test Procedure

Refer to ETSI EN 300 330 V2.1.1 (2017-02) Clause 6.3.2

### 15.4. Test Result

Receiver blocking or desensitization is only applicable for channelized systems where channel definitions are used, therefore this requirement does not apply.

## 16. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus:

Parameter	Uncertainty
RF frequency	$\pm 1 \times 10^{-7}$
RF Power, Conducted	$\pm 1\text{dB}$
RF Power, radiated	$\pm 6\text{dB}$
Temperature	$\pm 1^{\circ}\text{C}$
Humidity	$\pm 5\%$

## 17. List of Measuring Instrument

### Conducted Test Equipment - TR3

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Spectrum Analyzer	Agilent	N9020A	MRTSUE06106	1 year	2020/04/15
EXA Signal Analyzer	Keysight	N9010B	MRTSUE06452	1 year	2019/07/19
Signal Analyzer	R&S	FSV40	MRTSUE06218	1 year	2020/04/15
Power Meter	Agilent	U2021XA	MRTSUE06030	1 year	2019/11/16
USB wideband power sensor	Keysight	U2021XA	MRTSUE06446	1 year	2019/07/19
USB wideband power sensor	Keysight	U2021XA	MRTSUE06447	1 year	2019/07/05
Programmable Temperature & Humidity Chamber	BAOYT	BYH-1500L	MRTSUE06051	1 year	2019/11/16
Thermohygrometer	Testo	608-H1	MRTSUE06401	1 year	2019/08/14

### Transmitter Spurious Emissions and Receiver Spurious Emissions - AC1

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cal. Due Date
PXA Signal Analyzer	Keysight	N9030B	MRTSUE06395	1 year	2019/09/25
Microwave System Amplifier	Agilent	83017A	MRTSUE06076	1 year	2019/11/16
Bilog Period Antenna	Schwarzbeck	VULB 9168	MRTSUE06172	1 year	2020/03/31
Broad Band Horn Antenna	Schwarzbeck	BBHA9120D	MRTSUE06023	1 year	2019/10/19
Thermohygrometer	Testo	608-H1	MRTSUE06403	1 year	2019/08/14
Anechoic Chamber	TDK	Chamber-AC1	MRTSUE06212	1 year	2019/05/01

### Transmitter Spurious Emissions and Receiver Spurious Emissions - AC2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Spectrum Analyzer	Keysight	N9038A	MRTSUE06125	1 year	2019/08/13
Bilog Period Antenna	Schwarzbeck	VULB 9162	MRTSUE06022	1 year	2019/10/19
Horn Antenna	Schwarzbeck	BBHA9120D	MRTSUE06171	1 year	2019/11/09
Broadband Coaxial Preamplifier	Schwarzbeck	BBV 9718	MRTSUE06176	1 year	2019/11/16
Temperature/Humidity Meter	Minggao	ETH529	MRTSUE06170	1 year	2019/12/13
Anechoic Chamber	RIKEN	Chamber-AC2	MRTSUE06213	1 year	2019/05/01

### Adjacent Channel Selectivity - SR5

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Spectrum Analyzer	Agilent	N9020A	MRTSUE06106	1 year	2020/04/15
EXA Signal Analyzer	Keysight	N9010B	MRTSUE06452	1 year	2019/07/19
Signal Analyzer	R&S	FSV40	MRTSUE06218	1 year	2020/04/15
Vector Signal Generator	Agilent	E4438C	MRTSUE06026	1 year	2019/11/16
MXG X-Series Microwave Analog Signal Generator	Keysight	N5183B	MRTSUE06197	1 year	2020/04/15
Thermohygrometer	Testo	608-H1	MRTSUE06402	1 year	2019/08/14

### Receiver Blocking - SR5

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Spectrum Analyzer	Agilent	N9020A	MRTSUE06106	1 year	2020/04/15
EXA Signal Analyzer	Keysight	N9010B	MRTSUE06452	1 year	2019/07/19
Signal Analyzer	R&S	FSV40	MRTSUE06218	1 year	2020/04/15
Wideband Radio Communication Tester	R&S	CMW 500	MRTSUE06243	1 year	2019/11/16
Vector Signal Generator	R&S	SMBV100A	MRTSUE06279	1 year	2020/04/15
Bluetooth Test Set	Anritsu	MT8852B-042	MRTSUE06389	1 year	2019/06/14
Thermohygrometer	Testo	608-H1	MRTSUE06402	1 year	2019/08/14

Software	Version	Function
EMI Software	V3	EMI Test Software

\_\_\_\_\_ The End \_\_\_\_\_



## **Appendix A - Test Setup Photograph**

Refer to “1903RSU035-ET” file.

## **Appendix B - EUT Photograph**

Refer to "1903RSU035-EE" file.